

T-25-23

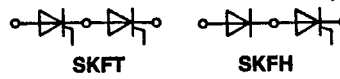
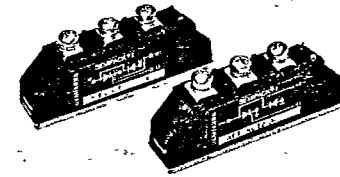
V _{DRM} V _{RRM} V	t _q (T _{vj} = 125 °C) μs	I _{TRMS} (maximum values for continuous operation)	
		75 A I _{TAV} (sin. 180; T _{case} = 89 °C; 50 Hz) 30 A	75 A 30 A
600	15 20	SKFT 30/06 DS SKFT 30/06 DT	- -
800	15 20	SKFT 30/08 DS SKFT 30/08 DT	- SKFH 30/08 DT
1000	15 20	SKFT 30/10 DS SKFT 30/10 DT	- SKFH 30/08 DT
1200	20 30	SKFT 30/12 DT SKFT 30/12 DV	SKFH 30/12 DT -

Symbol	Conditions	SKFT 30 SKFH 30 ¹⁾
I _{TM}	sin. 180; T _{case} = 60 °C; 500 Hz	150 A
I _{TSM}	T _{vj} = 25 °C T _{vj} = 125 °C	1000 A 900 A
i ² t	T _{vj} = 25 °C T _{vj} = 125 °C	5000 A ² s 4050 A ² s
t _{gd} t _{gr} (di/dt) _{cr} (dv/dt) _{cr}	T _{vj} = 25 °C; I _G = 1 A; di _G /dt = 1 A/μs V _D = 0,67 · V _{DRM} non-repetitive/f = 50 ... 60 Hz T _{vj} = 125 °C	1 μs 1 μs 600 A/μs / 125 A/μs 500 V/μs
I _H I _L	T _{vj} = 25 °C; typ./max. T _{vj} = 25 °C; R _G = 33 Ω; typ./max.	150 mA/300 mA 400 mA/1000 mA
V _T V _{T(RO)} r _T I _D ; I _R	T _{vj} = 125 °C; I _T = 150 A; max. T _{vj} = 125 °C T _{vj} = 125 °C T _{vj} = 125 °C; V _{DRM} ; V _{RRM}	2,25 V 1,7 V 4 mΩ 20 mA
V _{GT} I _{GT} V _{GD} I _{GD}	T _{vj} = 25 °C T _{vj} = 25 °C T _{vj} = 125 °C T _{vj} = 125 °C	3 V 100 mA 0,25 V 8 mA
R _{thjc} R _{thch} T _{vj} T _{stg}	cont. } per thyristor/per module	0,6/0,3 °C/W 0,2/0,1 °C/W -40 ... +125 °C -40 ... +125 °C
V _{isol} M ₁ M ₂ w	a. c. 50 Hz; r.m.s.; 1 s/1 min. Case to heatsink } SI units/ Busbars to terminals } US units approx.	3000 V ~ /2500 V ~ 5 Nm/44 lb. in. ± 15 % 3 Nm/26 lb. in. ± 15 % 120 g
Case	→ page B2-12	SKFT A5 SKFH A8

SEMIPACK® 1
Fast Thyristor/ Diode
Modules



SKFT 30 **SKFH 30**
Thyristor data¹⁾



Features

- Heat transfer through ceramic isolated metal baseplate
- Hard soldered joints for high reliability
- UL recognized, file no. 63 532

Typical Applications

- Self-commutated inverters
- DC choppers
- AC motor speed control
- Inductive heating
- Uninterruptible power supplies
- Electronic welders
- General power switching applications

¹⁾ For the data of the diode see page B2-7

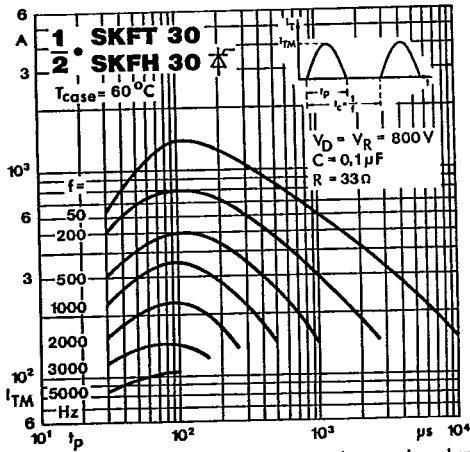


Fig. 1 a Rated peak on-state current vs. pulse duration

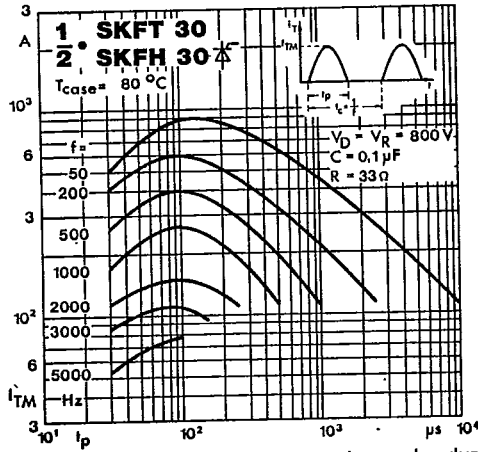


Fig. 1 b Rated peak on-state current vs. pulse duration

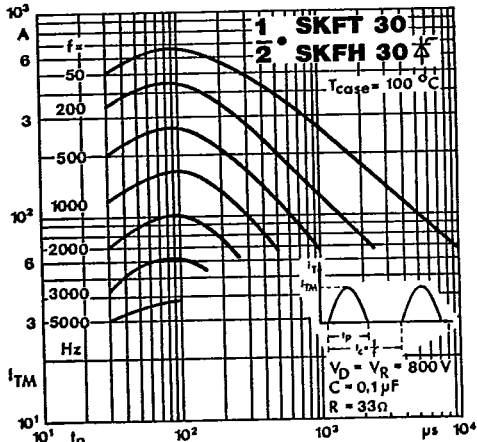


Fig. 1 c Rated peak on-state current vs. pulse duration

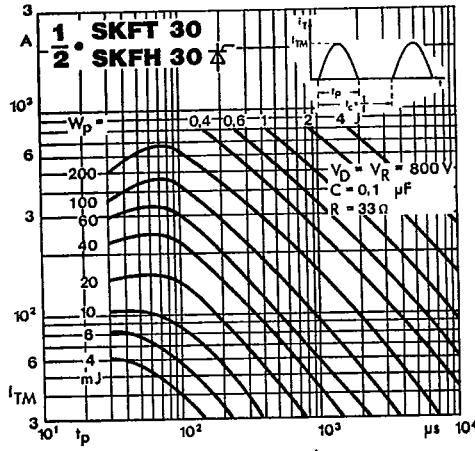


Fig. 2 Energy dissipation per pulse

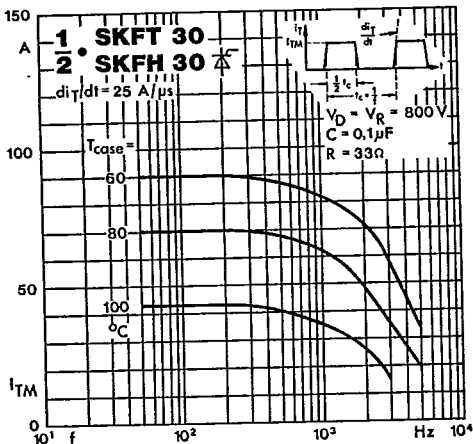


Fig. 3 a Rated peak on-state current vs. pulse duration

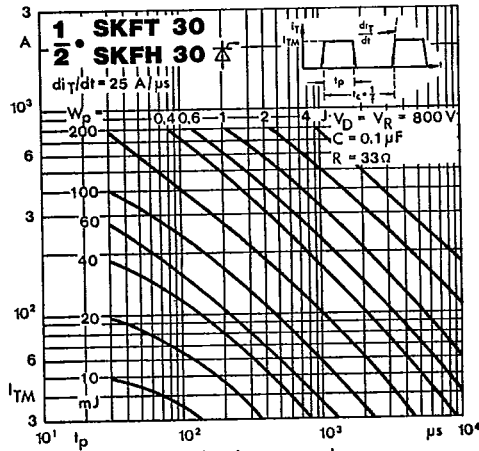


Fig. 4 a Energy dissipation per pulse

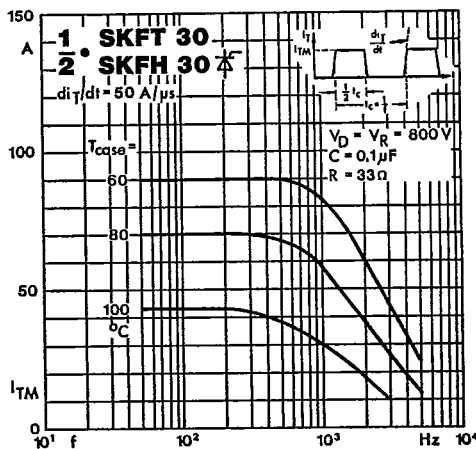


Fig. 3 b Rated peak on-state current vs. pulse duration

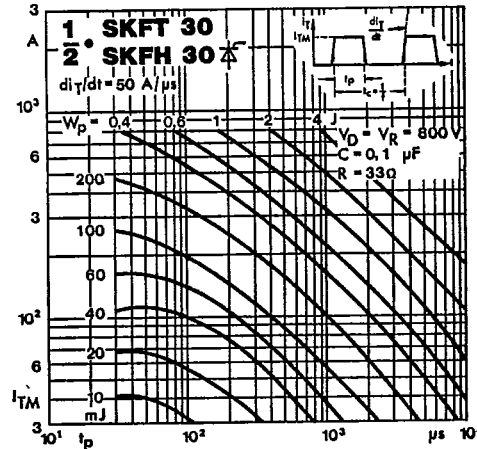


Fig. 4 b Energy dissipation per pulse

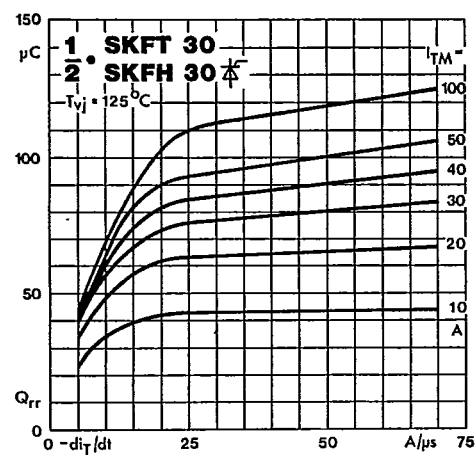


Fig. 5 Recovered charge vs. current decrease

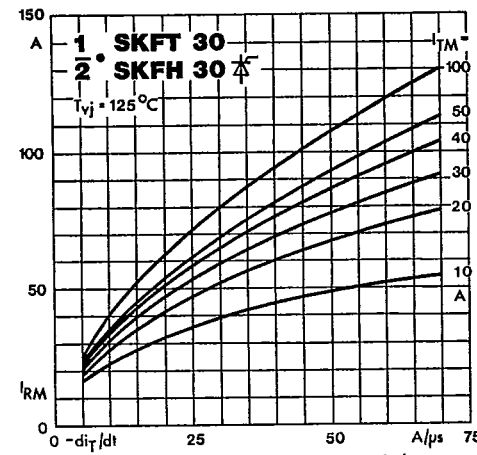


Fig. 6 Peak recovery current vs. current decrease

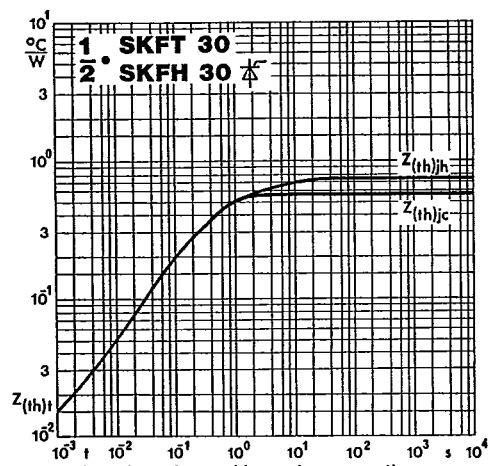


Fig. 7 Transient thermal impedance vs. time

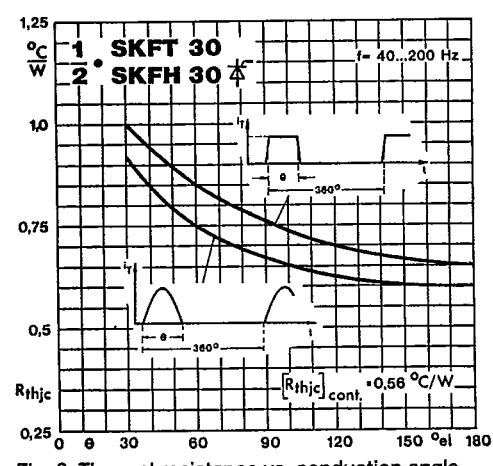


Fig. 8 Thermal resistance vs. conduction angle 40...200 Hz

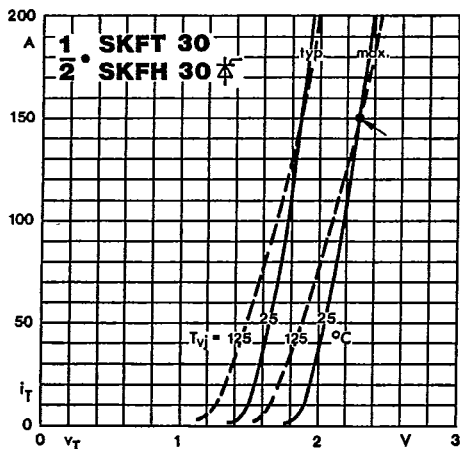


Fig. 9 On-state characteristics

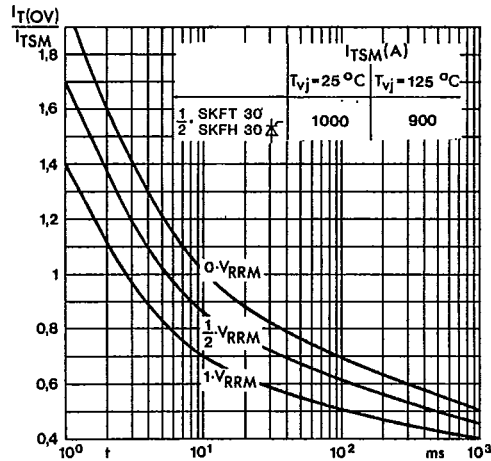


Fig. 10 Surge overload current vs. time

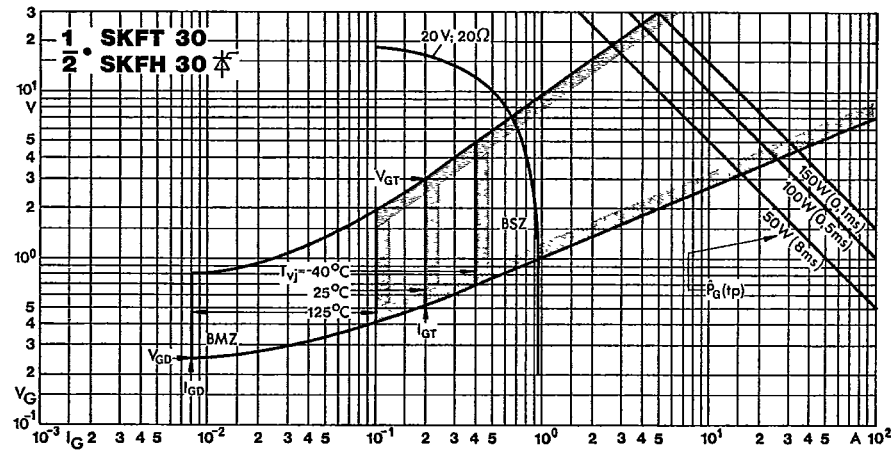


Fig. 11 Gate trigger characteristics